# RS-232 TRANSCEIVER WITH SPLIT SUPPLY PIN FOR LOGIC SIDE

**Check for Samples: TRS3386E**

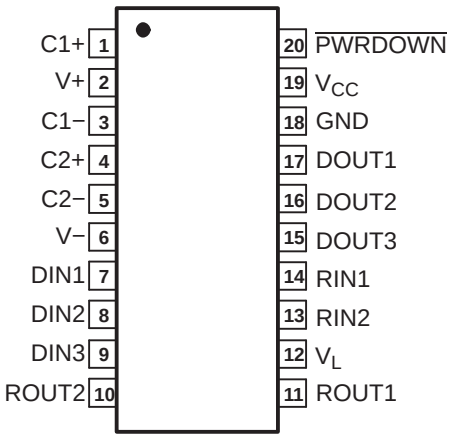
## FEATURES

- **$V_L$ Pin for Compatibility With Mixed-Voltage Systems Down to 2.5 V on Logic Side**
- **Enhanced ESD Protection on RIN Inputs and DOUT Outputs**
  - **±15-kV Human-Body Model**
  - **±15-kV IEC 61000-4-2, Air-Gap Discharge**
  - **±8-kV IEC 61000-4-2, Contact Discharge**
- **Low 300-µA Supply Current**
- **Specified 250-kbps Data Rate**
- **1-µA Low-Power Shutdown**
- **Meets EIA/TIA-232 Specifications Down to 3 V**
- **Designed to be Interchangeable With Industry Standard '3386 Devices**

## APPLICATIONS

- **Hand-Held Equipment**
- **PDAs**
- **Cell Phones**
- **Battery-Powered Equipment**
- **Data Cables**

**PW OR DW PACKAGE**
**TOP VIEW**




## DESCRIPTION/ORDERING INFORMATION

The TRS3386E is a three-driver and two-receiver RS-232 interface device, with split supply pins for mixed-signal operations. All RS-232 inputs and outputs are protected to ±15 kV using the IEC 61000-4-2 Air-Gap Discharge method, ±8 kV using the IEC 61000-4-2 Contact Discharge method, and ±15 kV using the Human-Body Model.

The charge pump requires only four small 0.1-µF capacitors for operation from a 3.3-V supply. The TRS3386E is capable of running at data rates up to 250 kbps, while maintaining RS-232-compliant output levels.

The TRS3386E has a unique $V_L$ pin that allows operation in mixed-logic voltage systems. Both driver in (DIN) and receiver out (ROUT) logic levels are pin programmable through the $V_L$ pin. The TRS3386E is available in a space-saving thin shrink small-outline package (TSSOP).

**ORDERING INFORMATION**

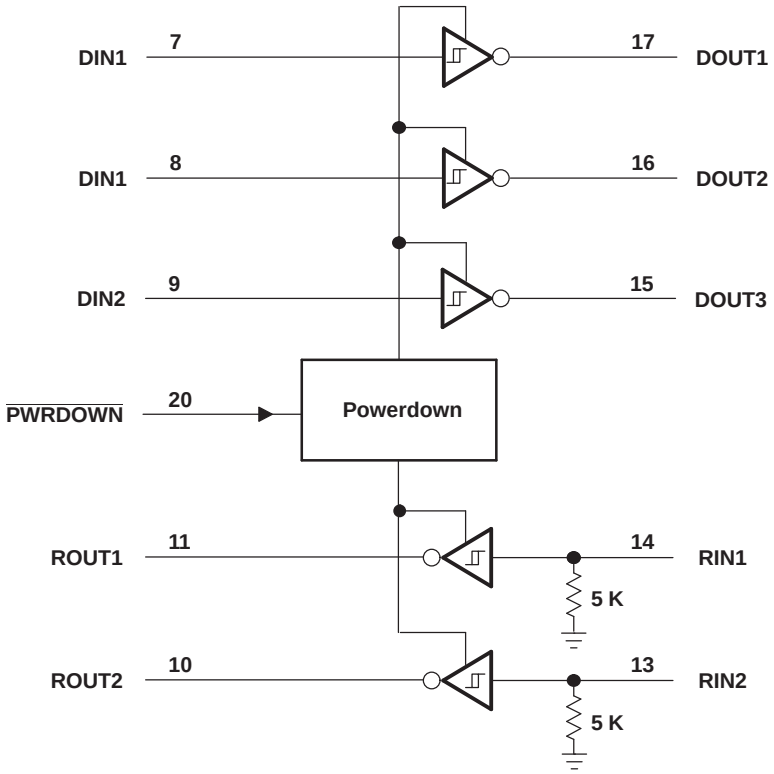
| $T_A$ | PACKAGE(1) (2) | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|---|---|---|---|
| 0°C to 70°C | TSSOP – PW | TRS3386ECPWR | RV86EC |
| | SOIC – DW | TRS3386ECDWR | TRS3386EC |
| –40°C to 85°C | TSSOP – PW | TRS3386EIPWR | RV86EI |
| | SOIC – DW | TRS3386EIDWR | TRS3386EI |

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.
(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

**Table 1. TRUTH TABLE (SHUTDOWN FUNCTION)**

| $\overline{\text{PWRDWN}}$ | DRIVER OUTPUTS | RECEIVER OUTPUTS | CHARGE PUMP |
|---|---|---|---|
| L | High-Z | High-Z | Inactive |
| H | Active | Active | Active |

## FUNCTIONAL BLOCK DIAGRAM



## TERMINAL FUNCTIONS

| TERMINAL | | DESCRIPTION |
|---|---|---|
| NAME | NO. | |
| C1+ | 1 | Positive terminal of the voltage-doubler charge-pump capacitor |
| V+ | 2 | 5.5-V supply generated by the charge pump |
| C1– | 3 | Negative terminal of the voltage-doubler charge-pump capacitor |
| C2+ | 4 | Positive terminal of the inverting charge-pump capacitor |
| C2– | 5 | Negative terminal of the inverting charge-pump capacitor |
| V– | 6 | –5.5-V supply generated by the charge pump |
| DIN1<br>DIN2<br>DIN3 | 7<br>8<br>9 | Driver inputs |
| ROUT2<br>ROUT1 | 10<br>11 | Receiver outputs. Swing between 0 and $V_L$. |
| $V_L$ | 12 | Logic-level supply. All CMOS inputs and outputs are referenced to this supply. |
| RIN2<br>RIN1 | 13<br>14 | RS-232 receiver inputs |
| DOUT3<br>DOUT2<br>DOUT1 | 15<br>16<br>17 | RS-232 driver outputs |
| GND | 18 | Ground |
| $V_{CC}$ | 19 | 3-V to 5.5-V supply voltage |
| $\overline{\text{PWRDWN}}$ | 20 | Powerdown input<br>L = Powerdown<br>H = Normal operation |

## Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|
| | $V_{CC}$ to GND | | –0.3 | 6 | V |
| | $V_L$ to GND | | –0.3 | $V_{CC}$ + 0.3 | V |
| | V+ to GND | | –0.3 | 7 | V |
| | V– to GND | | 0.3 | –7 | V |
| | V+ + \|V–\|(2) | | | 13 | V |
| $V_I$ | Input voltage | DIN, $\overline{\text{PWRDWN}}$ to GND | –0.3 | 6 | V |
| | | RIN to GND | | ±25 | |
| $V_O$ | Output voltage | DOUT to GND | | ±13.2 | V |
| | | ROUT | –0.3 | $V_L$ + 0.3 | |
| | Short-circuit duration DOUT to GND | | | Continuous | |
| | Continuous power dissipation | $T_A$ = 70°C, 20-pin TSSOP<br>(derate 7 mW/°C above 70°C) | | 559 | mW |
| $T_J$ | Junction temperature | | | 150 | °C |
| $T_{stg}$ | Storage temperature range | | –65 | 150 | °C |
| | Lead temperature (soldering, 10 s) | | | 300 | °C |

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(2) V+ and V– can have maximum magnitudes of 7 V, but their absolute difference cannot exceed 13 V.

## Recommended Operating Conditions

| | | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{CC}$ | Supply voltage | | | 3 | 5.5 | V |
| $V_L$ | Supply voltage | | | 2.25 | $V_{CC}$ | V |
| | Input logic threshold low | DIN, $\overline{PWRDWN}$ | $V_L$ = 3 V or 5.5 V | | 0.8 | V |
| | | | $V_L$ = 2.3 V | | 0.6 | |
| | Input logic threshold high | DIN, $\overline{PWRDWN}$ | $V_L$ = 5.5 V | 2.4 | | V |
| | | | $V_L$ = 3 V | 2.0 | | |
| | | | $V_L$ = 2.7 V | 1.4 | | |
| | Operating temperature | | TRS3386ECPWR | 0 | 70 | °C |
| | | | TRS3386EIPWR | –40 | 85 | |
| | Receiver input voltage | | | –25 | 25 | V |

## Electrical Characteristics

over operating free-air temperature range, $V_{CC}$ = $V_L$ = 3 V to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%) (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP(1) | MAX | UNIT |
|---|---|---|---|---|---|
| **DC Characteristics ($V_{CC}$ = 3.3 V or 5 V, $T_A$ = 25°C)** | | | | | |
| Powerdown supply current | $\overline{PWRDWN}$ = GND, All inputs at $V_{CC}$ or GND | | 1 | 10 | µA |
| Supply current | $\overline{PWRDWN}$ = $V_{CC}$, No load | | 0.3 | 1 | mA |

(1) Typical values are at $V_{CC}$ = $V_L$ = 3.3 V, $T_A$ = 25°C.

## ESD Protection

| PARAMETER | TEST CONDITIONS | TYP | UNIT |
|---|---|---|---|
| RIN, DOUT | Human-Body Model | ±15 | kV |
| | IEC 61000-4-2 Air-Gap Discharge | ±15 | |
| | IEC 61000-4-2 Contact Discharge | ±8 | |

## RECEIVER SECTION

### Electrical Characteristics

over operating free-air temperature range, $V_{CC}$ = $V_L$ = 3 V to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), $T_A$ = $T_{MIN}$ to $T_{MAX}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | MIN | TYP(1) | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| $I_{off}$ | Output leakage current | ROUT, receivers disabled | | | ±0.05 | ±10 | µA |
| $V_{OL}$ | Output voltage low | $I_{OUT}$ = 1.6 mA | | | | 0.4 | V |
| $V_{OH}$ | Output voltage high | $I_{OUT}$ = –1 mA | | $V_L$ – 0.6 | $V_L$ – 0.1 | | V |
| $V_{IT–}$ | Input threshold low | $T_A$ = 25°C | $V_L$ = 5 V | 0.8 | 1.2 | | V |
| | | | $V_L$ = 3.3 V | 0.6 | 1.5 | | |
| $V_{IT+}$ | Input threshold high | $T_A$ = 25°C | $V_L$ = 5 V | | 1.8 | 2.4 | V |
| | | | $V_L$ = 3.3 V | | 1.5 | 2.4 | |
| $V_{hys}$ | Input hysteresis | | | | 0.5 | | V |
| | Input resistance | $T_A$ = 25°C | | 3 | 5 | 7 | kΩ |

(1) Typical values are at $V_{CC}$ = $V_L$ = 3.3 V, $T_A$ = 25°C

### Switching Characteristics

over operating free-air temperature range, $V_{CC}$ = $V_L$ = 3 V to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), $T_A$ = $T_{MIN}$ to $T_{MAX}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | TYP(1) | UNIT |
|---|---|---|---|---|
| $t_{PHL}$ | Receiver propagation delay | Receiver input to receiver output, $C_L$ = 150 pF | 0.15 | µs |
| $t_{PLH}$ | | | 0.15 | |
| $t_{PHL}$ – $t_{PLH}$ | Receiver skew | | 50 | ns |
| $t_{en}$ | Receiver output enable time | From $\overline{PWRDWN}$ | 200 | ns |
| $t_{dis}$ | Receiver output disable time | From $\overline{PWRDWN}$ | 200 | ns |

(1) Typical values are at $V_{CC}$ = $V_L$ = 3.3 V, $T_A$ = 25°C.

## DRIVER SECTION

### Electrical Characteristics

over operating free-air temperature range, $V_{CC}$ = $V_L$ = 3 V to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), $T_A$ = $T_{MIN}$ to $T_{MAX}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP(1) | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{OH}$ | Output voltage swing | All driver outputs loaded with 3 kΩ to ground | ±5 | ±5.4 | | V |
| $r_O$ | Output resistance | $V_{CC}$ = V+ = V– = 0, Driver output = ±2 V | 300 | 10M | | Ω |
| $I_{OS}$ | Output short-circuit current | $V_{T\_OUT}$ = 0 | | | ±60 | mA |
| $I_{OZ}$ | Output leakage current | $V_{T\_OUT}$ = ±12 V, Driver disabled, $V_{CC}$ = 0 or 3 V to 5.5 V | | | ±25 | µA |
| | Driver input hysteresis | | | | 0.5 | V |
| | Input leakage current | DIN, $\overline{PWRDWN}$ | | ±0.01 | ±1 | µA |

(1) Typical values are at $V_{CC}$ = $V_L$ = 3.3 V, $T_A$ = 25°C

### Timing Requirements

over operating free-air temperature range, $V_{CC}$ = $V_L$ = 3 V to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), $T_A$ = $T_{MIN}$ to $T_{MAX}$ (unless otherwise noted)

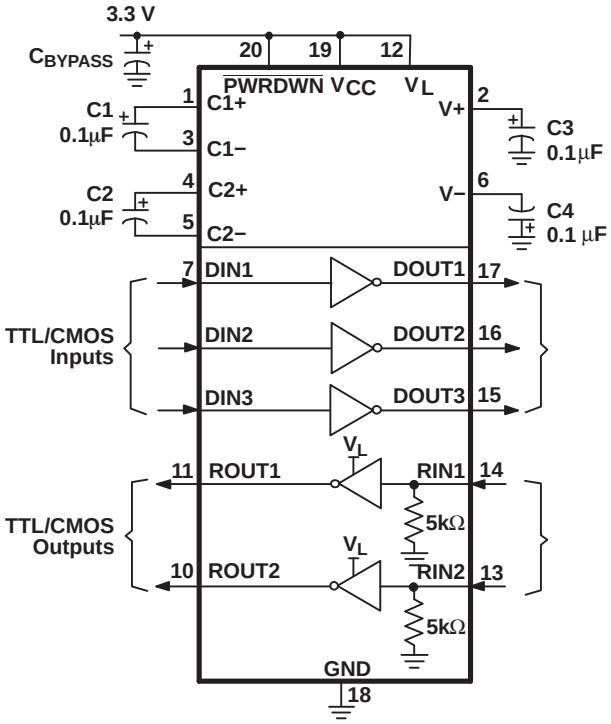
| PARAMETER | | | | MIN | TYP(1) | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| | Maximum data rate | $R_L$ = 3 kΩ, $C_L$ = 1000 pF, One driver switching | | 250 | | | kbps |
| | Time-to-exit powerdown | $\|V_{T\_OUT}\|$ > 3.7 V | | | 100 | | µs |
| $\|t_{PHL} – t_{PLH}\|$ | Driver skew(2) | | | | 100 | | ns |
| | Transition-region slew rate | $V_{CC}$ = 3.3 V, $T_A$ = 25°C, $R_L$ = 3 kΩ to 7 kΩ, Measured from 3 V to –3 V or –3 V to 3 V | $C_L$ = 150 pF to 1000 pF | 6 | | 30 | V/µs |
| | | | $C_L$ = 150 pF to 2500 pF | 4 | | 30 | |

(1) Typical values are at $V_{CC}$ = $V_L$ = 3.3 V, $T_A$ = 25°C.
(2) Driver skew is measured at the driver zero crosspoint.

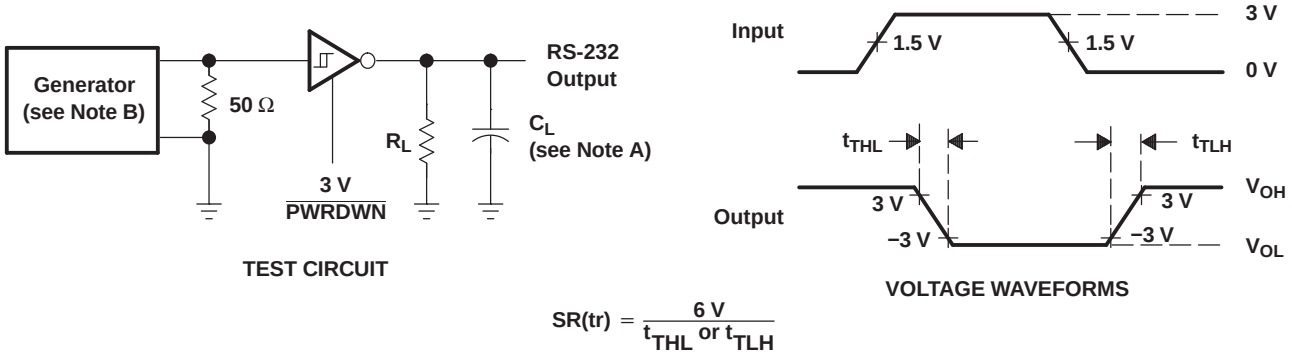
### ESD Protection

| PARAMETER | TEST CONDITIONS | TYP | UNIT |
|---|---|---|---|
| RIN, DOUT | Human-Body Model | ±15 | kV |
| | IEC 61000-4-2 Air-Gap Discharge | ±15 | |
| | IEC 61000-4-2 Contact Discharge | ±8 | |

## APPLICATION INFORMATION



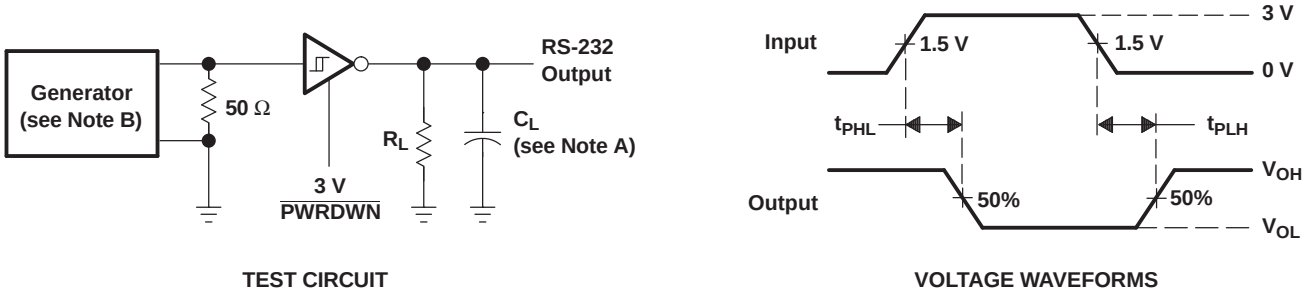
## PARAMETER MEASUREMENT INFORMATION




$$SR(tr) = \frac{6\ V}{t_{THL} \text{ or } t_{TLH}}$$

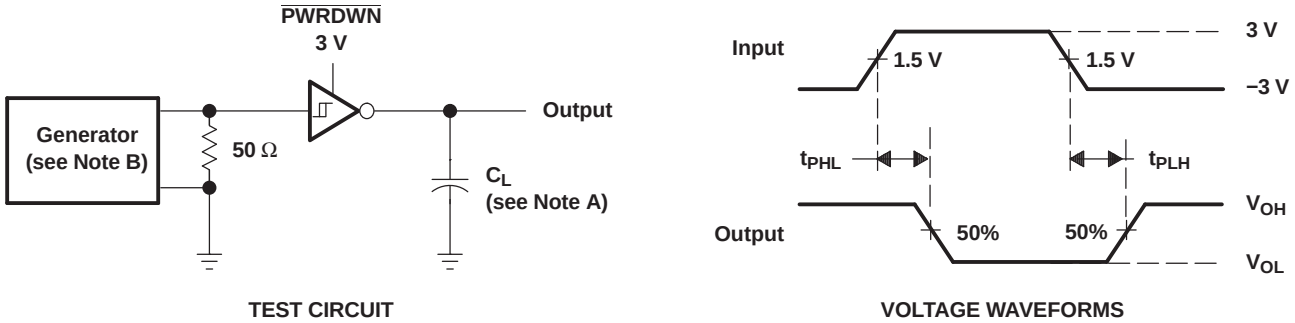
NOTES: A. $C_L$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_O$ = 50 Ω, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

**Figure 1. Driver Slew Rate**




NOTES: A. $C_L$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_O$ = 50 Ω, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

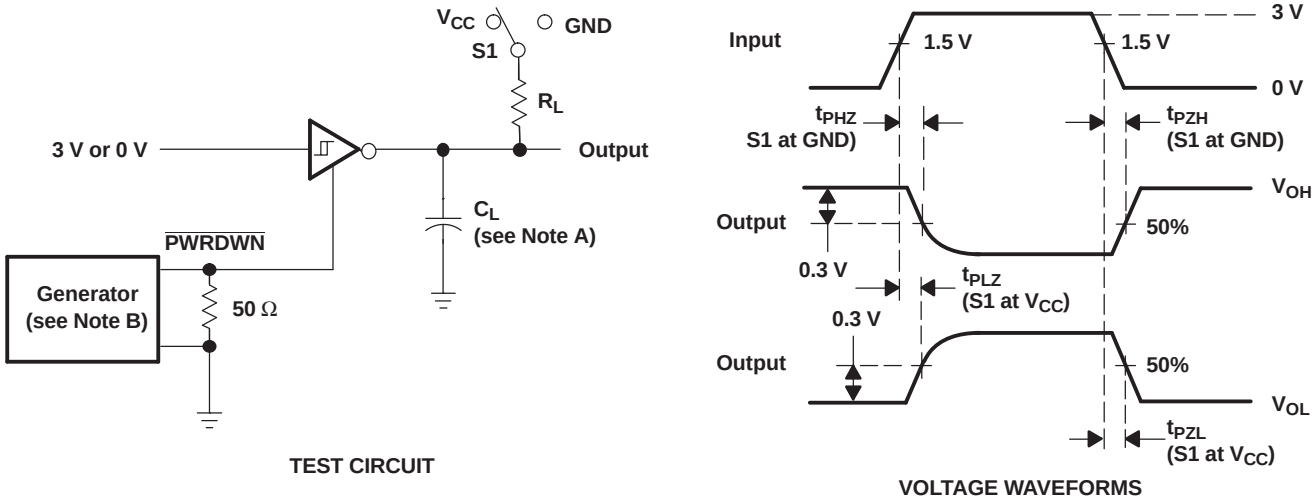
**Figure 2. Driver Pulse Skew**




NOTES: A. $C_L$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $Z_O$ = 50 Ω, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

**Figure 3. Receiver Propagation Delay Times**

## PARAMETER MEASUREMENT INFORMATION (Continued)




NOTES: A. $C_L$ includes probe and jig capacitance.
B. The pulse generator has the following characteristics: $Z_O$ = 50 Ω, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

**Figure 4. Receiver Enable and Disable Times**

## REVISION HISTORY

**Changes from Revision B (April 2009) to Revision C** **Page**

- Changed $V_L$ Pin for Compatibility With Mixed-Voltage Systems Down to 2.5 V (originally 1.8 V) on the Logic Side. ..... 1
- Changed $V_L$ Supply MIN value from 1.65 V to 2.25 V. ..... 4
- Deleted $V_L$ = 1.65V parameter from Input logic threshold low. ..... 4
- Deleted $V_L$ = 1.95V parameter from Input logic threshold high. ..... 4

## PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|---|---|---|---|---|---|---|---|---|---|---|---|
| TRS3386ECDWR | ACTIVE | SOIC | DW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | TRS3386EC | Samples |
| TRS3386ECPW | ACTIVE | TSSOP | PW | 20 | 70 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | RV86EC | Samples |
| TRS3386ECPWR | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | RV86EC | Samples |
| TRS3386ECPWRG4 | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | RV86EC | Samples |
| TRS3386EIDWR | ACTIVE | SOIC | DW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | TRS3386EI | Samples |
| TRS3386EIPW | ACTIVE | TSSOP | PW | 20 | 70 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | RV86EI | Samples |
| TRS3386EIPWR | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | RV86EI | Samples |

(1) The marketing status values are defined as follows:
**ACTIVE:** Product device recommended for new designs.
**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.
**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

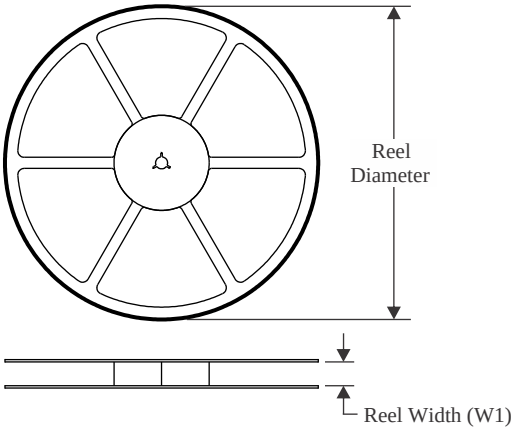
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

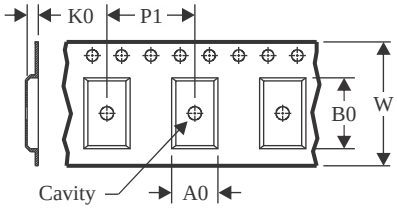
**(6)** Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

## TAPE AND REEL INFORMATION

**REEL DIMENSIONS**

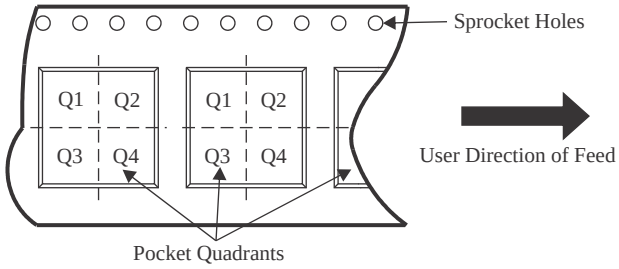



**TAPE DIMENSIONS**




| | |
|---|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

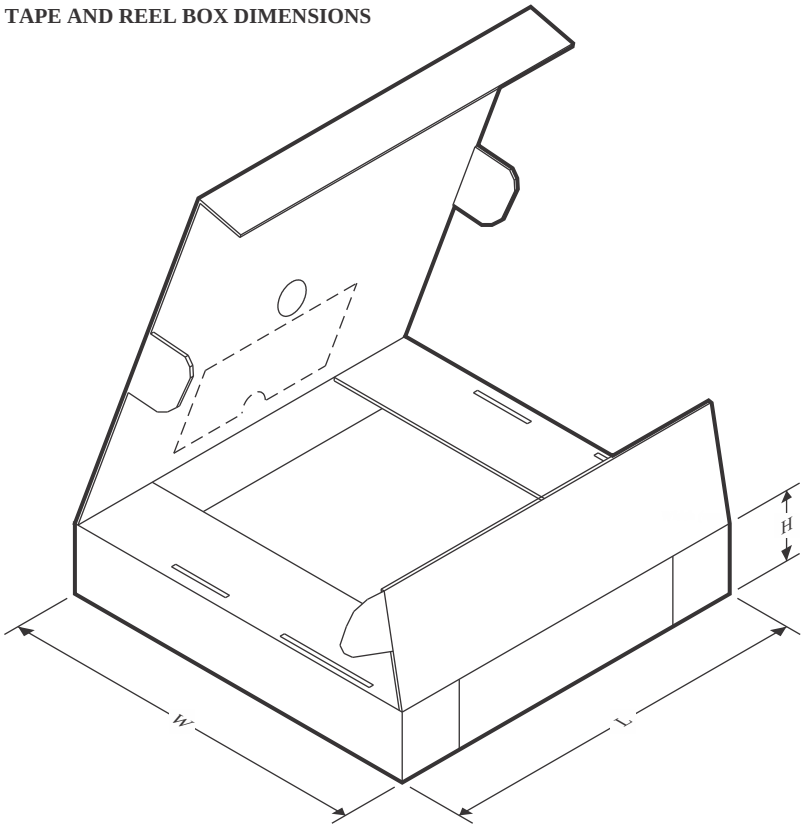
**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---|---|---|---|---|---|---|---|---|---|---|---|---|
| TRS3386ECDWR | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.8 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| TRS3386ECPWR | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.0 | 1.4 | 8.0 | 16.0 | Q1 |
| TRS3386EIDWR | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.8 | 13.3 | 2.7 | 12.0 | 24.0 | Q1 |
| TRS3386EIPWR | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |

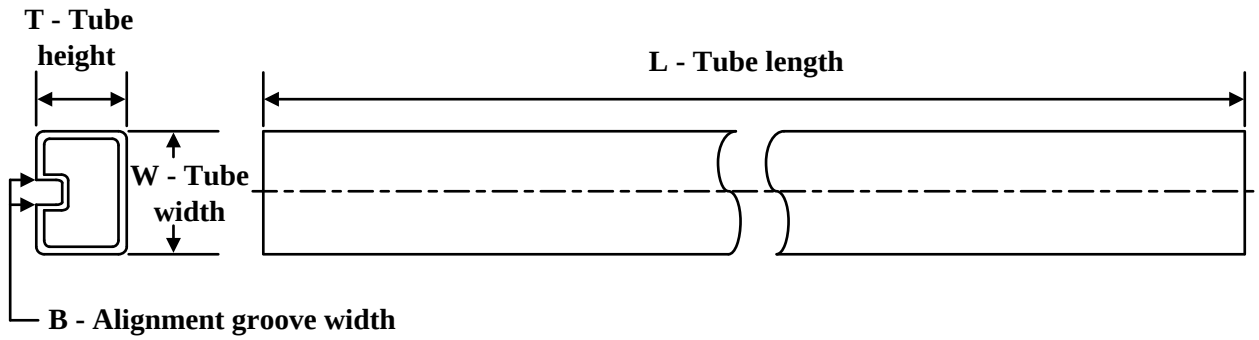
TAPE AND REEL BOX DIMENSIONS




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---|---|---|---|---|---|---|---|
| TRS3386ECDWR | SOIC | DW | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| TRS3386ECPWR | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |
| TRS3386EIDWR | SOIC | DW | 20 | 2000 | 367.0 | 367.0 | 45.0 |
| TRS3386EIPWR | TSSOP | PW | 20 | 2000 | 356.0 | 356.0 | 35.0 |

## TUBE




*All dimensions are nominal

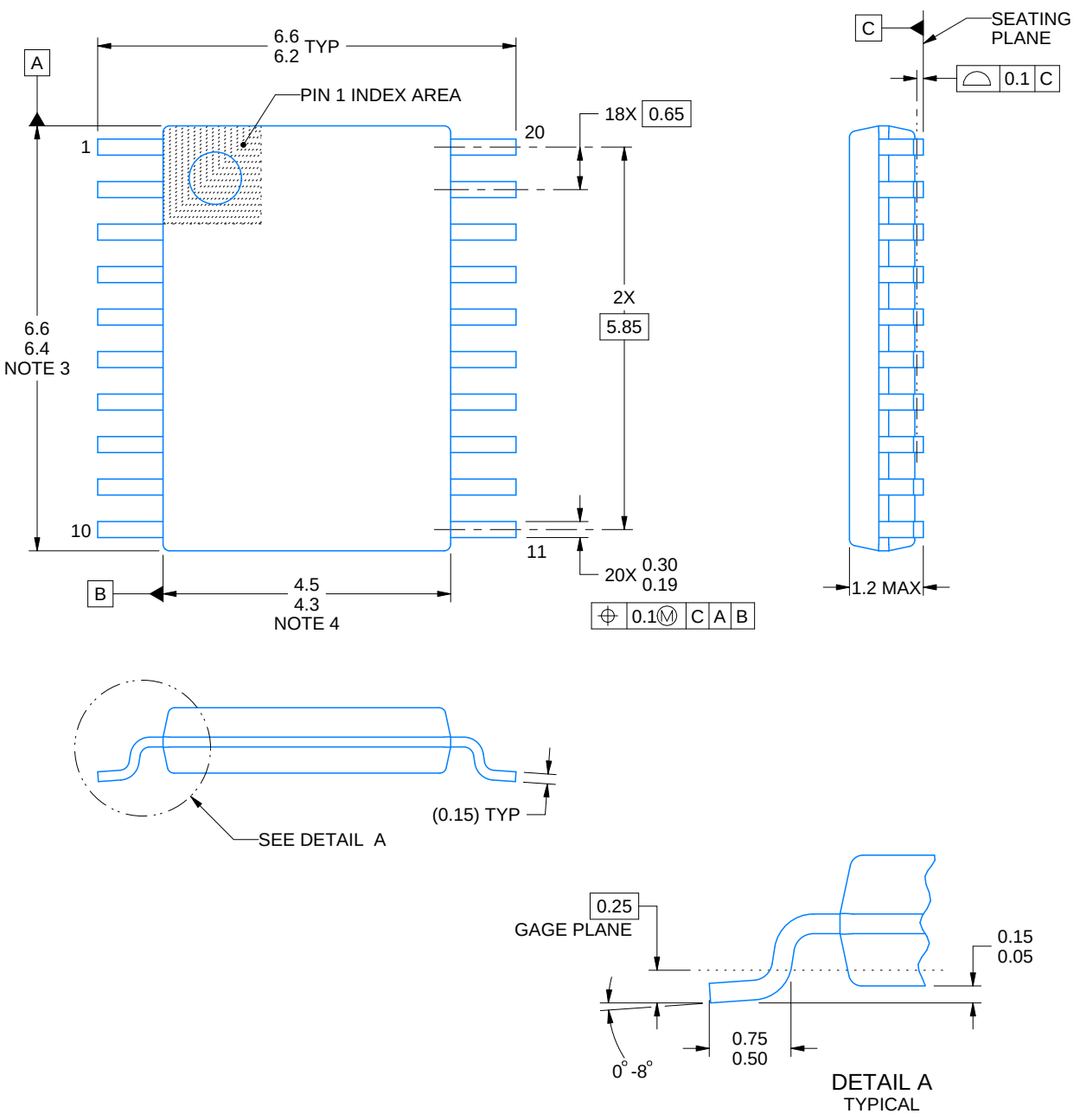
| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|---|---|---|---|---|---|---|---|---|
| TRS3386ECPW | PW | TSSOP | 20 | 70 | 530 | 10.2 | 3600 | 3.5 |
| TRS3386EIPW | PW | TSSOP | 20 | 70 | 530 | 10.2 | 3600 | 3.5 |

# PACKAGE OUTLINE

## PW0020A

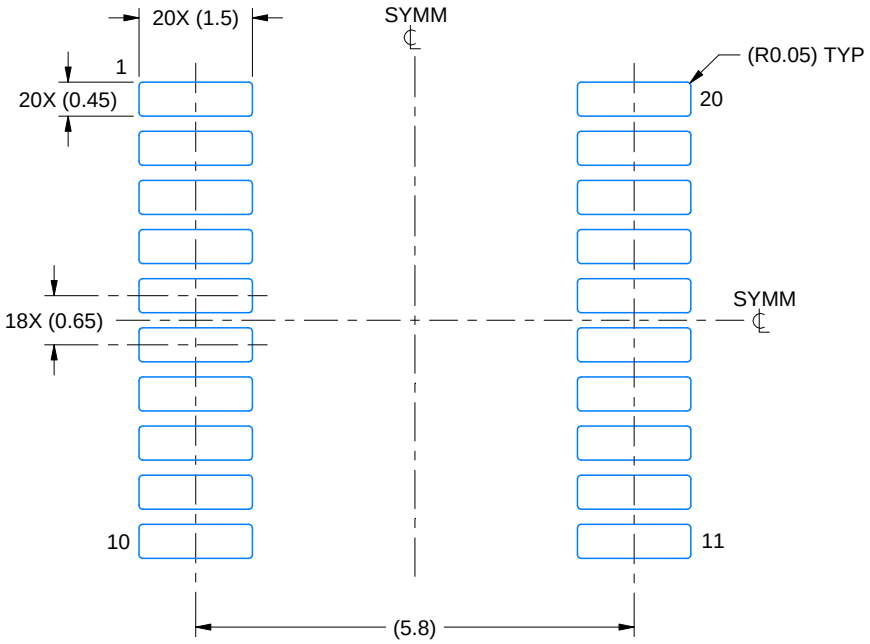
## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE




NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



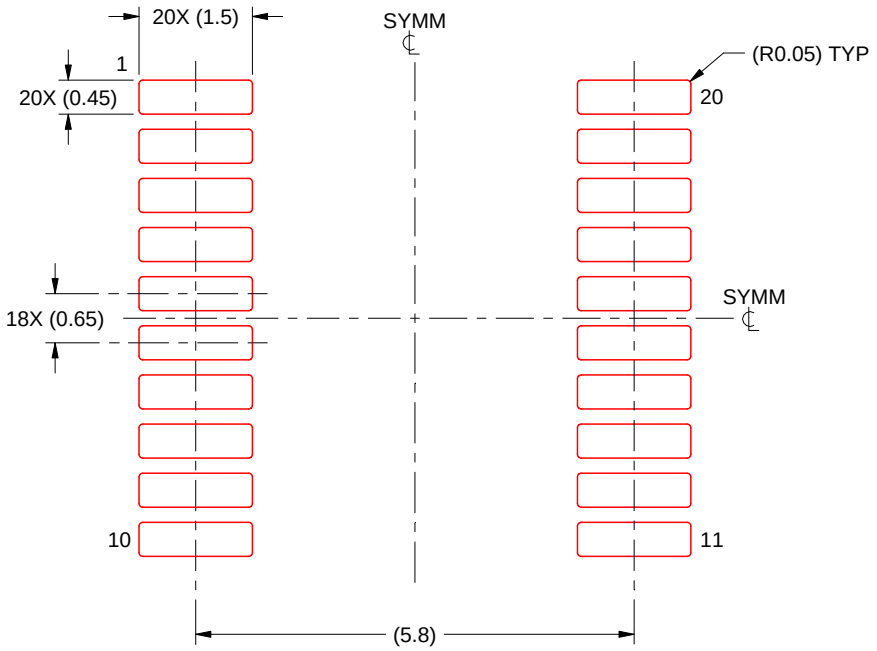

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X


SOLDER MASK DETAILS

4220206/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



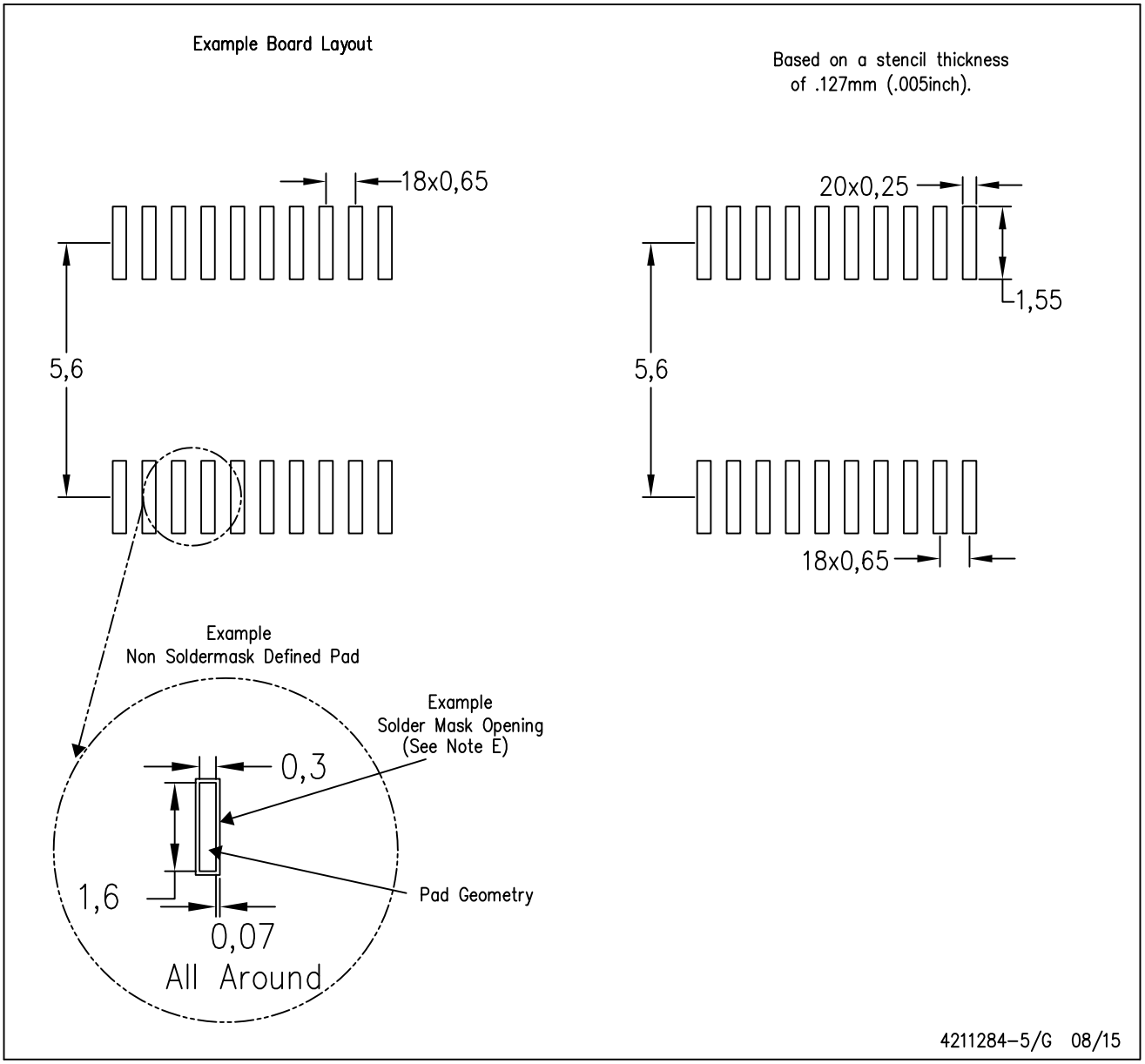

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220206/A 02/2017

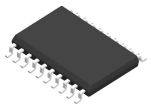
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

PW (R–PDSO–G20) PLASTIC SMALL OUTLINE




NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate design.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

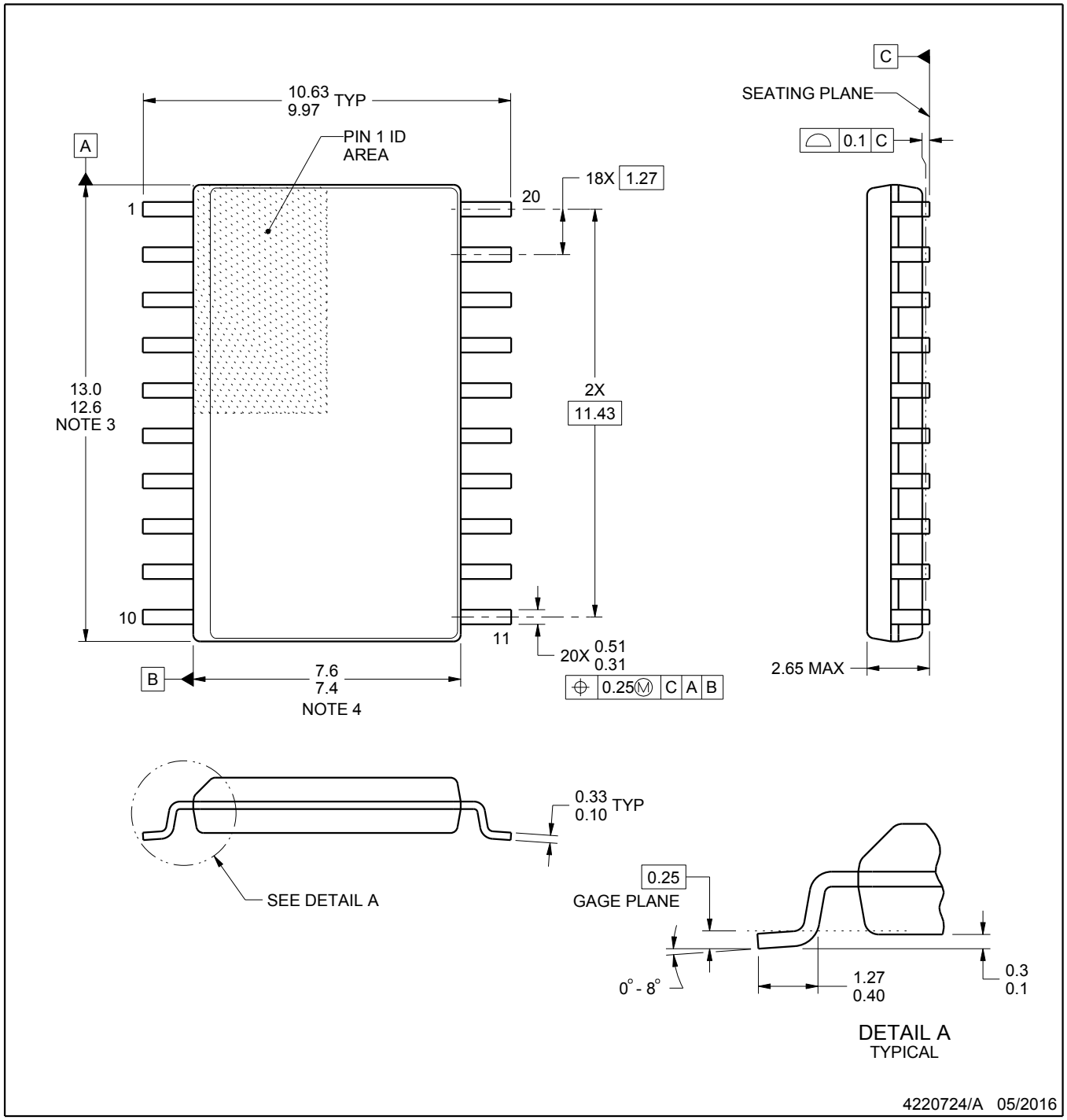


# PACKAGE OUTLINE

## DW0020A

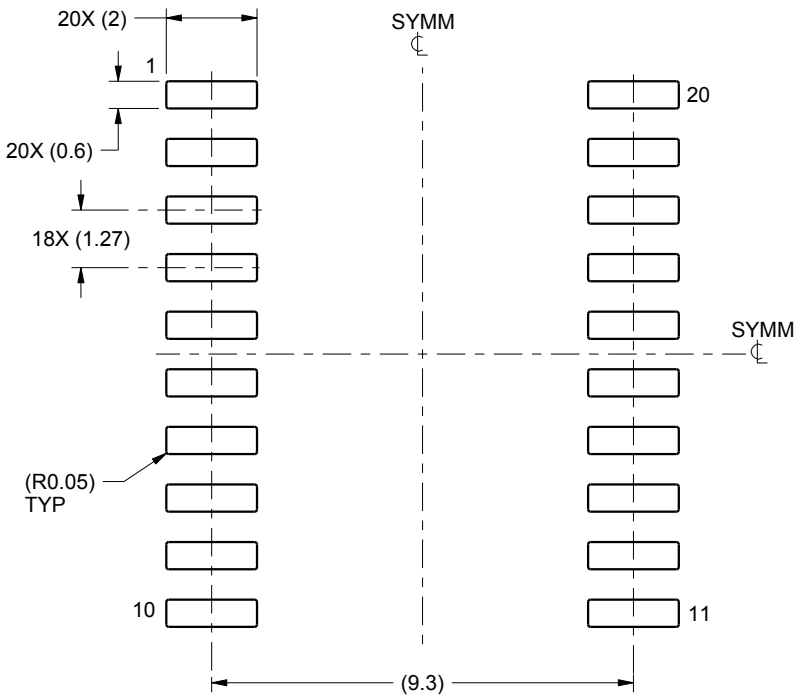
## SOIC - 2.65 mm max height

SOIC

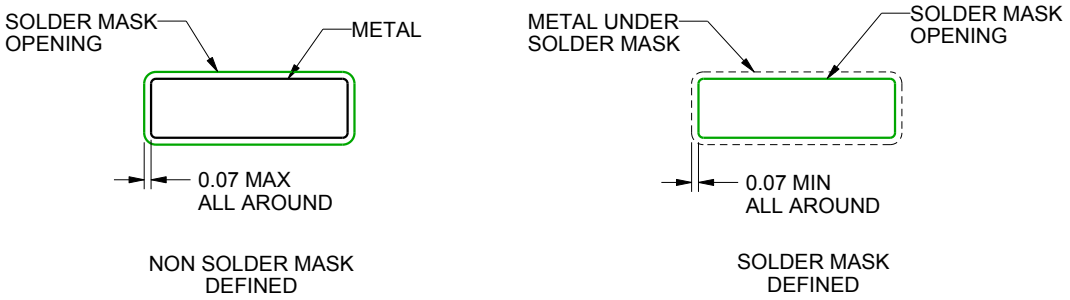



NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.




LAND PATTERN EXAMPLE
SCALE:6X

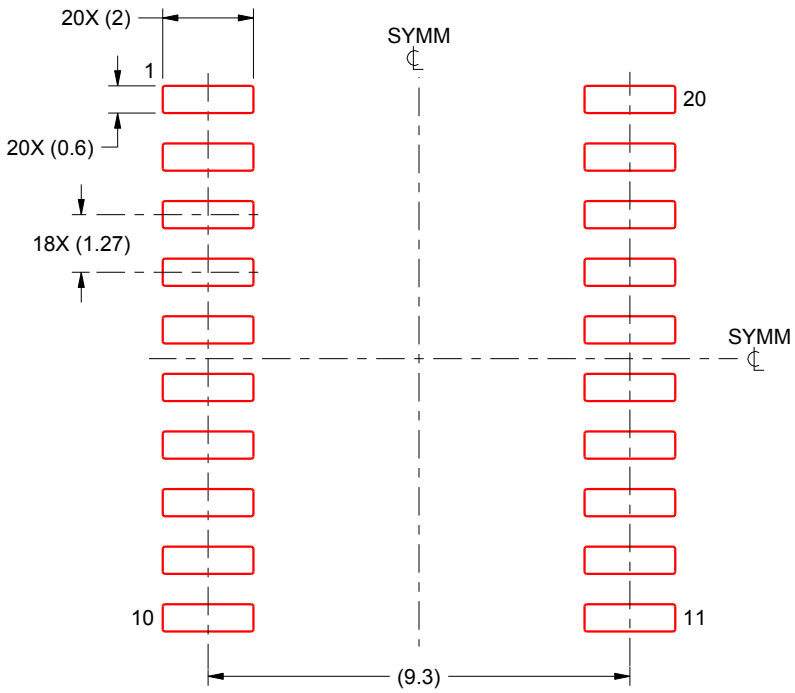



SOLDER MASK DETAILS

4220724/A 05/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.




SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

4220724/A 05/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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